

Amendments to the Claims:

This listing of the claims will replace all prior versions, and listings, of the claims in the application:

Listing of Claims:

1. (Currently Amended) A method for determining a cross sectional dimension of a measured structural element having a sub-micron cross section, the cross sectional dimension defining an intermediate section of the measured structural element that is located between first and second traverse sections of the measured structural element, the method comprising the steps of:

scanning, while an inspection tool is in a first tilt state, a reference structural element and at least the first traverse section of the measured structural element, to determine a first distance between a certain point of the reference structural element and the first traverse section, wherein the first traverse section represents a first edge of the measured structural element;

scanning, while the inspection tool is in a second tilt state, the reference structural element and at least the second traverse section of the measured structural element, to determine a second distance between the certain point of the reference structural element and the second traverse section, wherein the second traverse section represents a second edge of the measured structural element; and

determining a cross sectional dimension of the intermediate section of the measured structural element ~~by statistically averaging in response to~~ the first and second distances, wherein the cross sectional dimension is located between ~~[[a]]~~ the first and second traverse section sections of the measured structural element.

2. (Cancelled)

3. (Currently Amended) The method of claim ~~[[2]]~~ 1 wherein the first edge of the measured structural element and the certain point of the reference structural element are substantially located on a same plane.

4. (Original) The method of claim 1 wherein a height of the certain point of the reference structural element is much smaller than a height of the measured structural element.

5. (Previously Presented) The method of claim 1 further comprising a preliminary step of generating the reference structural element at a vicinity of the measured structural element.
6. (Previously Presented) The method of claim 1 wherein during the scanning, while the inspection tool is in the first tilt stage, a measurement angle defined between a measured object that includes the measured structural element and an electron beam that scans the measured structural element is substantially ninety degrees.
7. (Currently Amended) The method of claim 1 wherein at least one additional reference structural element is provided at a vicinity of the reference structural element and wherein the steps of scanning further comprise scanning the at least one additional reference structural element to provide at least a third relationship distance, in addition to the first and second relationships distances, between the at least one additional reference structural element and a traverse section of the measured structural element.
8. (Currently Amended) The method of claim 7 wherein the step of determining is further responsive to the third relationship distance.
9. (Previously Presented) The method of claim 1 wherein after scanning, while the inspection tool is in the first tilt state, determining whether to perform additional scanning.
10. (Previously Presented) The method of claim 9 wherein performing the scanning, while the inspection tool is in the second tilt state, is in response to determining a feature of the first traverse section.
11. (Previously Presented) The method of claim 10 wherein the feature is an estimated width or an estimated orientation of the first traverse section.
12. (Previously Presented) The method of claim 11 wherein the orientation is estimated by comparing detection signals generated as a result of a scan of the first traverse section and

detection signals generated as a result of at least one scan of another traverse section of known width.

13. (Currently Amended) The method of claim 9 wherein at least one additional reference structural element is provided at a vicinity of the reference structural element and wherein the steps of scanning further comprise scanning the at least one additional reference structural element to provide at least a third relationship distance, in addition to the first and second relationships distances, between the at least one additional reference structural element and a traverse section of the measured structural element.

14. (Currently Amended) The method of claim 13 wherein the step of determining is further responsive to the third relationship distance.

15. (Currently Amended) A method for determining a cross sectional dimension of a measured structural element having a sub-micron cross section, the cross sectional dimension defining an intermediate section of the measured structural element that is located between first and second traverse sections of the measured structural element, the method comprising the steps of:

scanning, while an inspection tool is in a first tilt state, at least a first point of a first reference structural element and at least the first traverse section of the measured structural element, to determine a first distance between the first reference structural element and the first traverse section, wherein the first traverse section represents a first edge of the measured structural element;

scanning, while the inspection tool is in a second tilt state, at least a second point of a second reference structural element and at least the second traverse section of the measured structural element, to determine a second distance between the second reference structural element and the second traverse section, wherein the second traverse section represents a second edge of the measured structural element; and

determining a cross sectional dimension of the intermediate section of the measured structural element ~~by statistically averaging~~ in response to the first and second distances, wherein the cross sectional dimension is located between [[a]] the first and second traverse section sections of the measured structural element.

16. (Original) The method of claim 15 wherein the measured structural element is positioned between the first and second reference structural elements.
17. (Original) The method of claim 15 further comprising a step of measuring a distance between the first and second points.
18. (Previously Presented) The method of claim 17 wherein the measured structural element is positioned between the first and second reference structural elements and wherein the step of measuring the distance comprises performing at least one scan of the first and second points and the measured structural element.
19. (Previously Presented) The method of claim 18 wherein the at least one scan comprises preventing an electron beam from illuminating the measured structural element.
20. (Previously Presented) The method of claim 15 wherein the measured structural element is a line that has a top section and two substantially opposing sidewalls.
21. (Previously Presented) The method of claim 15 wherein the measured structural element is a contact.
22. (Previously Presented) The method of claim 15 wherein the measured structural element is a recess.
23. (Currently Amended) The method of claim 15 wherein at least one additional reference structural element is provided at a vicinity of the first and second reference structural elements and wherein the steps of scanning further comprise scanning the at least one additional reference structural element to provide a third ~~relationship~~ distance, in addition to the first and second ~~relationships~~ distances, between the at least one additional reference structural element and a traverse section of the measured structural element.

24. (Currently Amended) The method of claim 23 wherein the step of determining is further responsive to the third ~~relationship~~ distance.

25. (Previously Presented) The method of claim 15 wherein after scanning, while the inspection tool is in the first tilt state, determining whether additional scanning is required.

26. (Previously Presented) The method of claim 25 wherein the scanning, while the inspection tool is in the first tilt stage, comprises scanning with an electron beam that is substantially perpendicular to a measured object that includes the measured structural element.

27. (Previously Presented) The method of claim 25 wherein the determination of whether additional scanning is required is responsive to an estimated width of a traverse section.

28. (Previously Presented) The method of claim 25 wherein the determination of whether additional scanning is required is responsive to an estimated orientation of a traverse section.

29. (Previously Presented) The method of claim 25 wherein the determination of whether additional scanning is required is responsive to an estimated cross sectional dimension of the measured structural element.

30. (Currently Amended) The method of claim 25 wherein the determination of whether additional scanning is required is responsive to a ~~relationship~~ distance between a threshold and an estimated cross sectional dimension of the measured structural element.

31. (Previously Presented) The method of claim 30 wherein the threshold is a maximal width of the measured structural element.

32. (Previously Presented) The method of claim 30 wherein the threshold is a minimal width of the measured structural element.

33 - 34. (Cancelled)

35. (Currently Amended) The method of claim 25 wherein at least one additional reference structural element is provided at a vicinity of the first and second reference structural elements and wherein the steps of scanning further comprise scanning the at least one additional reference structural element to provide a third ~~relationship~~ distance, in addition to the first and second ~~relationships~~ distances, between the at least one additional reference structural element and a traverse section of the measured structural element.

36. (Currently Amended) The method of claim 35 wherein the step of determining is further responsive to the third ~~relationship~~ distance.

37. (Currently Amended) A method for determining a cross sectional dimension of a measured structural element having a sub-micron cross section, the cross sectional dimension defining an intermediate section of the measured structural element that is located between first and second traverse sections of the measured structural element, the method comprising the steps of:

scanning, while an inspection tool is in a first tilt state, first portions of a set of reference structural elements and at least the first traverse section of the measured structural element, to determine a first set of distances between first certain points of reference structural elements of the set of reference structural elements and the first traverse section, wherein the first traverse section represents a first edge of the measured structural element;

scanning, while the inspection tool is in a second tilt state, second portions of the set of reference structural elements and at least the second traverse section of the measured structural element, to determine a second set of distances between second certain points of reference structural elements of the set of reference structural elements and the second traverse section, wherein the second traverse section represents a second edge of the measured structural element; and

determining a cross sectional dimension of the intermediate section of the measured structural element ~~by statistically averaging in response to~~ the first and second distances, wherein the cross sectional dimension is located between ~~[[a]]~~ the first and second traverse section ~~sections~~ of the measured structural element.

38. (Currently Amended) The method of claim 37 wherein the step of determining comprises statistical processing of the ~~relationships~~ distances of the first set to provide the first ~~relationship~~ distance.

39. (Currently Amended) The method of claim 37 wherein the step of determining comprises statistical processing of the ~~relationships~~ distances of the second set to provide the second ~~relationship~~ distance.

40. (Original) The method of claim 37 wherein the set of reference structural elements is positioned at both sides of the measured structural element.

41. (Original) The method of claim 37 wherein the set of reference structural elements is positioned at one side of the measured structural element.

42. (Currently Amended) A system for determining a cross sectional dimension of a structural element having a sub-micron cross section, the cross sectional dimension defining an intermediate section that is located between first and second traverse sections of the structural element, wherein the first traverse section represents a first edge of the measured structural element and the second traverse section represents a second edge of the measured structural element, the system comprising:

means for directing an electron beam towards an inspected object including the structural element so as to scan, at a first tilt state, a reference structural element and at least the first traverse section of the structural element, and to scan at a second tilt state, the reference structural element and at least the second traverse section of the structural element;

at least one detector that is positioned so as to detect electrons emitted from the structural element as a result of an interaction with the electron beam; and

a processor, coupled to the at least one detector and to the directing means so as to process detection signals received from the at least one detector and to:

determine a first distance between a certain point of the reference structural element and the first traverse section;

determine a second distance between the certain point of the reference structural

element and the second traverse section; and

determine a cross sectional dimension of the intermediate section of the measured structural element ~~by statistically averaging in response to~~ the first and second distances, wherein the cross sectional dimension is located between ~~[[a]]~~ the first and second traverse ~~section~~ sections of the measured structural element.

43. (Cancelled)

44. (Currently Amended) The system of claim 42 wherein the processor is capable of determining the cross sectional dimension in response to additional ~~relationships~~ distances between the structural element and additional reference structural elements.

45. (Previously Presented) The system of claim 42 wherein the processor is configured to determine whether to perform an additional scan after the scan at the first tilt state is performed.